

**Notice of References Cited**

Application/Control No.

09/181,001

Applicant(s)/Patent Under  
Reexamination  
VAN LIEMPD ET AL.

Examiner

Tia A Carter

Art Unit

2622

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	A	US-5600779-	02-1997	Palmer et al.	395	340
*	B	US-5585891-	12-1996	Altrieth et al.	355	209
*	C	US-4873570-	10-1989	Suzuki et al.	358	80
	D	US-6208427-	03-2001	Lee	358	1.15
	E	US-5353399-	10-1994	Kuwamoto et al.	395	159
	F	US-5095448-	05-1992	Obuchi et al.	395	144
	G	US-5287448-	02-1994	Nicol et al.	395	159
	H	US-5481667-	01-1996	Bieniek et al.	395	161
	I	US-6100994-	08-2000	Schliekelmann et al.	358	1.15
	J	US-4772882-	09-1988	Mical	340	709
	K	US-5859638-	01-1999	Coleman et al.	345	341
	L	US-5602996-	02-1997	Powers, III et al.	395	344
	M	US- -				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
*	N	-0745929-	12-1996	E.P.O		G06F	3/12
	O	- -					
	P	- -					
	Q	- -					
	R	- -					
	S	- -					
	T	- -					

**NON-PATENT DOCUMENTS**

	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
in MM-YYYY format are publication dates. Classifications may be US or foreign.